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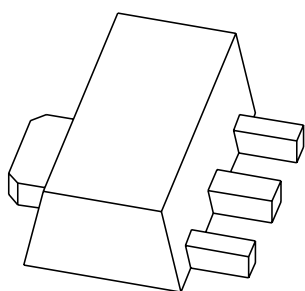
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If you have any questions related to the data sheet, please contact our nearest sales office via e-mail or telephone (details via **salesaddresses@nexperia.com**). Thank you for your cooperation and understanding,

Kind regards,

Team Nexperia

DATA SHEET



PBSS4350X

50 V, 3 A

NPN low V_{CEsat} (BISS) transistor

Product specification
Supersedes data of 2003 Nov 21

2004 Nov 04

50 V, 3 A
NPN low V_{CEsat} (BISS) transistor

PBSS4350X

FEATURES

- SOT89 (SC-62) package
- Low collector-emitter saturation voltage V_{CEsat}
- High collector current capability: I_C and I_{CM}
- Higher efficiency leading to less heat generation
- Reduced printed-circuit board requirements.

APPLICATIONS

- Power management
 - DC/DC converters
 - Supply line switching
 - Battery charger
 - LCD backlighting.
- Peripheral drivers
 - Driver in low supply voltage applications (e.g. lamps and LEDs).
 - Inductive load driver (e.g. relays, buzzers and motors).

DESCRIPTION

NPN low V_{CEsat} transistor in a SOT89 plastic package.
PNP complement: PBSS5350X.

MARKING

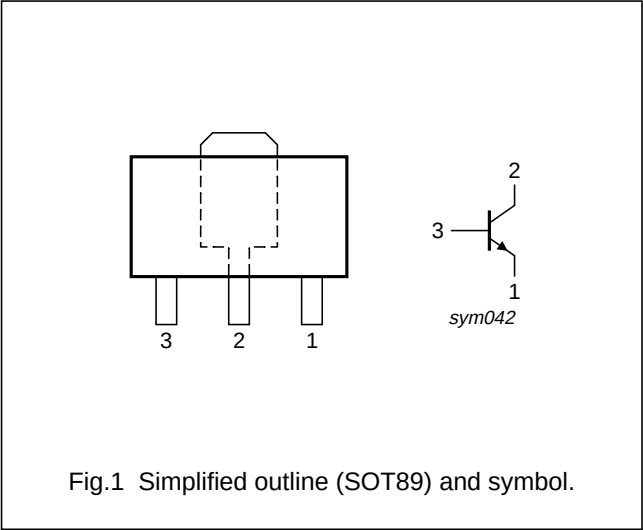
TYPE NUMBER	MARKING CODE
PBSS4350X	S43

QUICK REFERENCE DATA

SYMBOL	PARAMETER	MAX.	UNIT
V_{CEO}	collector-emitter voltage	50	V
I_C	collector current (DC)	3	A
I_{CM}	peak collector current	5	A
R_{CEsat}	equivalent on-resistance	130	mΩ

PINNING

PIN	DESCRIPTION
1	emitter
2	collector
3	base



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PBSS4350X

ORDERING INFORMATION

TYPE NUMBER	PACKAGE		
	NAME	DESCRIPTION	VERSION
PBSS4350X	SC-62	plastic surface mounted package; collector pad for good heat transfer; 3 leads	SOT89

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 60134).

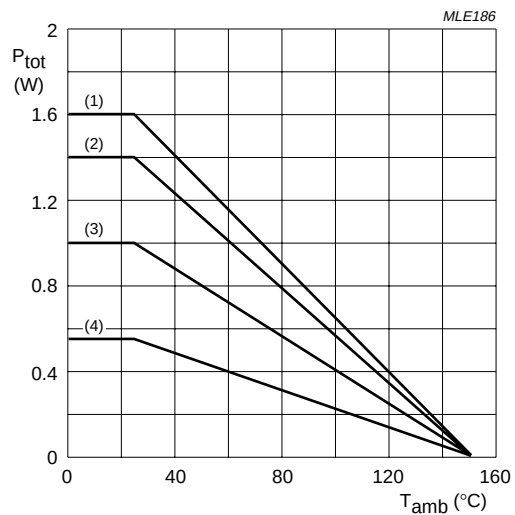
SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V_{CBO}	collector-base voltage	open emitter	–	50	V
V_{CEO}	collector-emitter voltage	open base	–	50	V
V_{EBO}	emitter-base voltage	open collector	–	5	V
I_C	collector current (DC)	note 4	–	3	A
I_{CM}	peak collector current	limited by $T_{j(max)}$	–	5	A
I_B	base current (DC)		–	0.5	A
P_{tot}	total power dissipation	$T_{amb} \leq 25\text{ °C}$ note 1 note 2 note 3 note 4	– – – –	550 1 1.4 1.6	mW W W W
T_{stg}	storage temperature		–65	+150	°C
T_j	junction temperature		–	150	°C
T_{amb}	ambient temperature		–65	+150	°C

Notes

1. Device mounted on a FR4 printed-circuit board; single-sided copper; tin-plated; standard footprint.
2. Device mounted on a FR4 printed-circuit board; single-sided copper; tin-plated; mounting pad for collector 1 cm².
3. Device mounted on a FR4 printed-circuit board; single-sided copper; tin-plated; mounting pad for collector 6 cm².
4. Device mounted on a ceramic printed-circuit board 7 cm², single-sided copper, tin-plated.

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NPN low V_{CEsat} (BISS) transistor

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- | | |
|---|---|
| (1) Ceramic PCB; 7 cm ² mounting pad for collector. | (3) FR4 PCB; 1 cm ² copper mounting pad for collector. |
| (2) FR4 PCB; 6 cm ² copper mounting pad for collector. | (4) Standard footprint. |

Fig.2 Power derating curves.

50 V, 3 A

NPN low V_{CEsat} (BISS) transistor

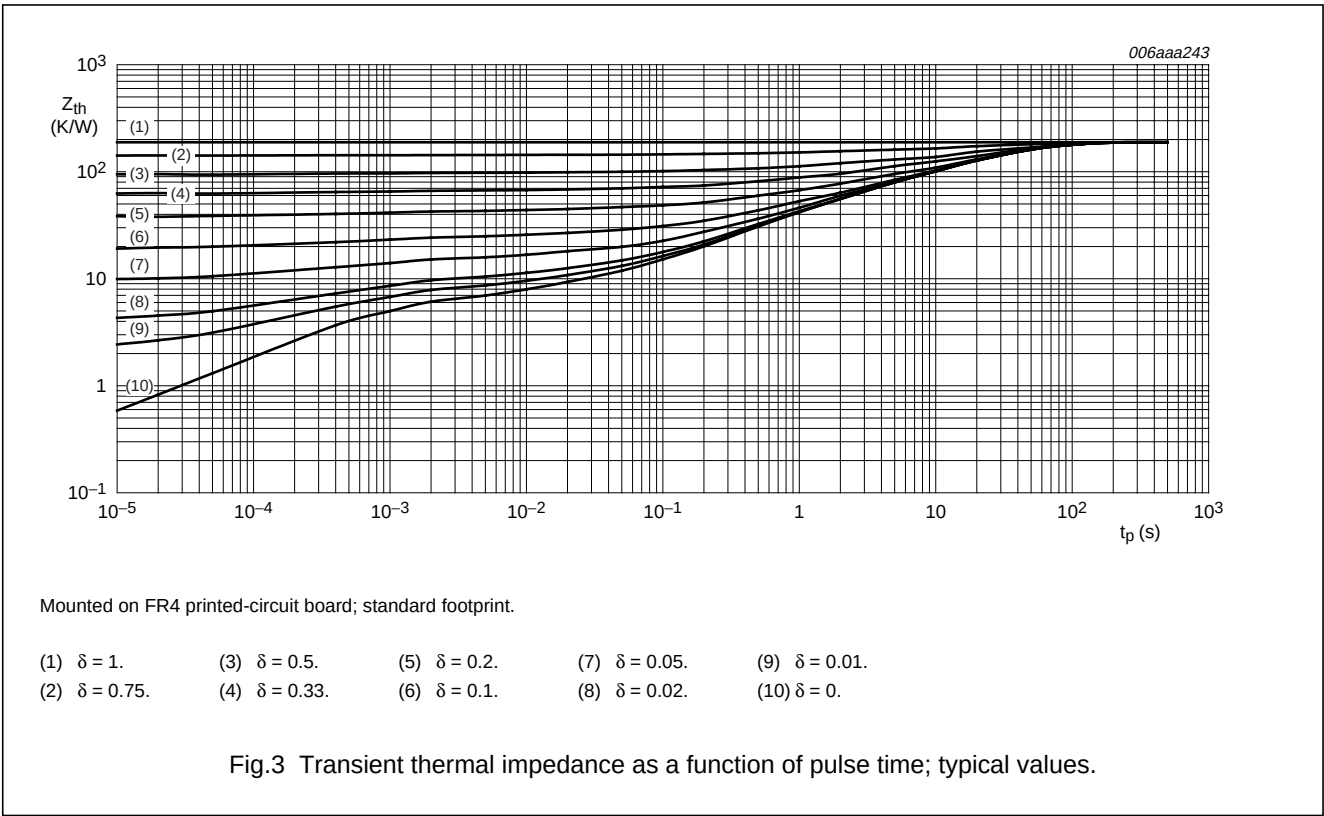
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THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
$R_{th(j-a)}$	thermal resistance from junction to ambient	in free air		
		note 1	225	K/W
		note 2	125	K/W
		note 3	90	K/W
		note 4	80	K/W
$R_{th(j-s)}$	thermal resistance from junction to soldering point		16	K/W

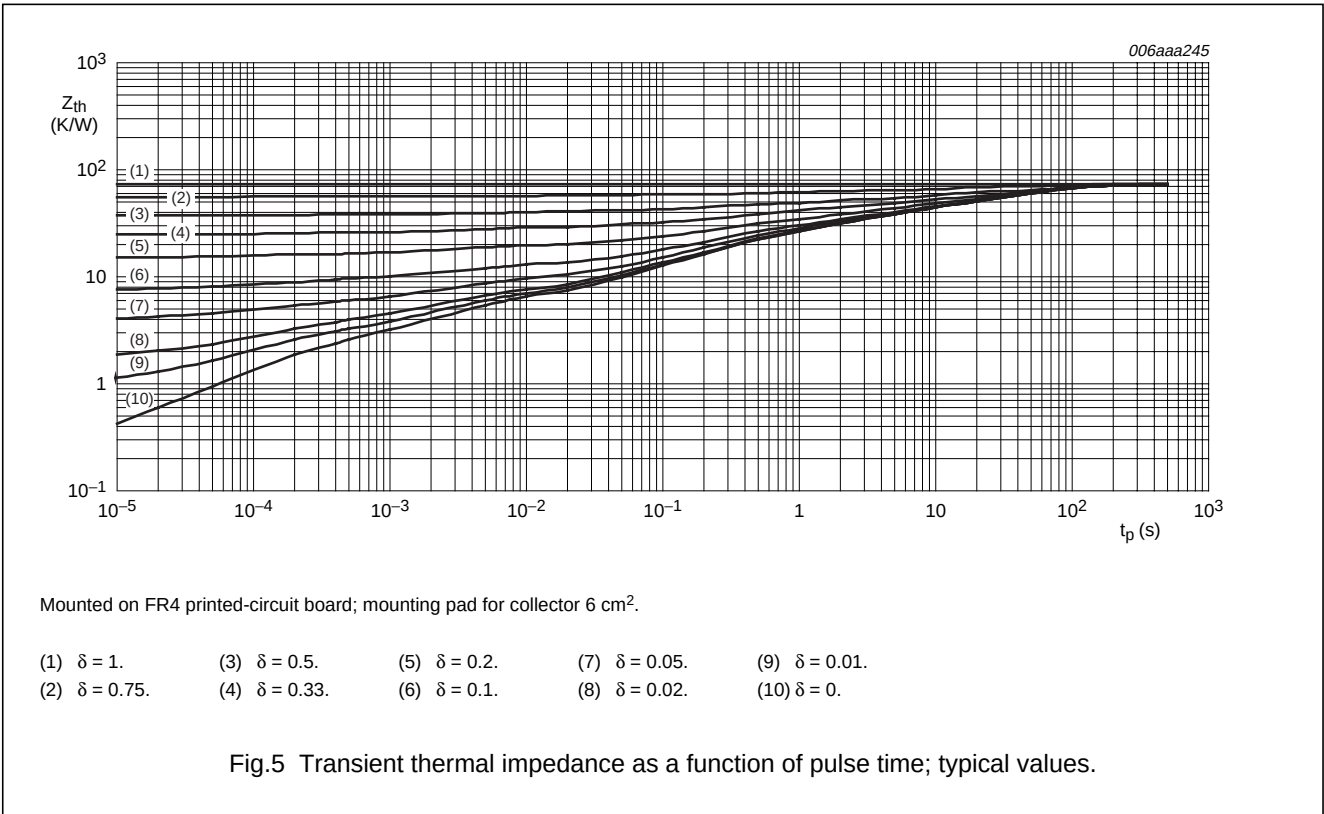
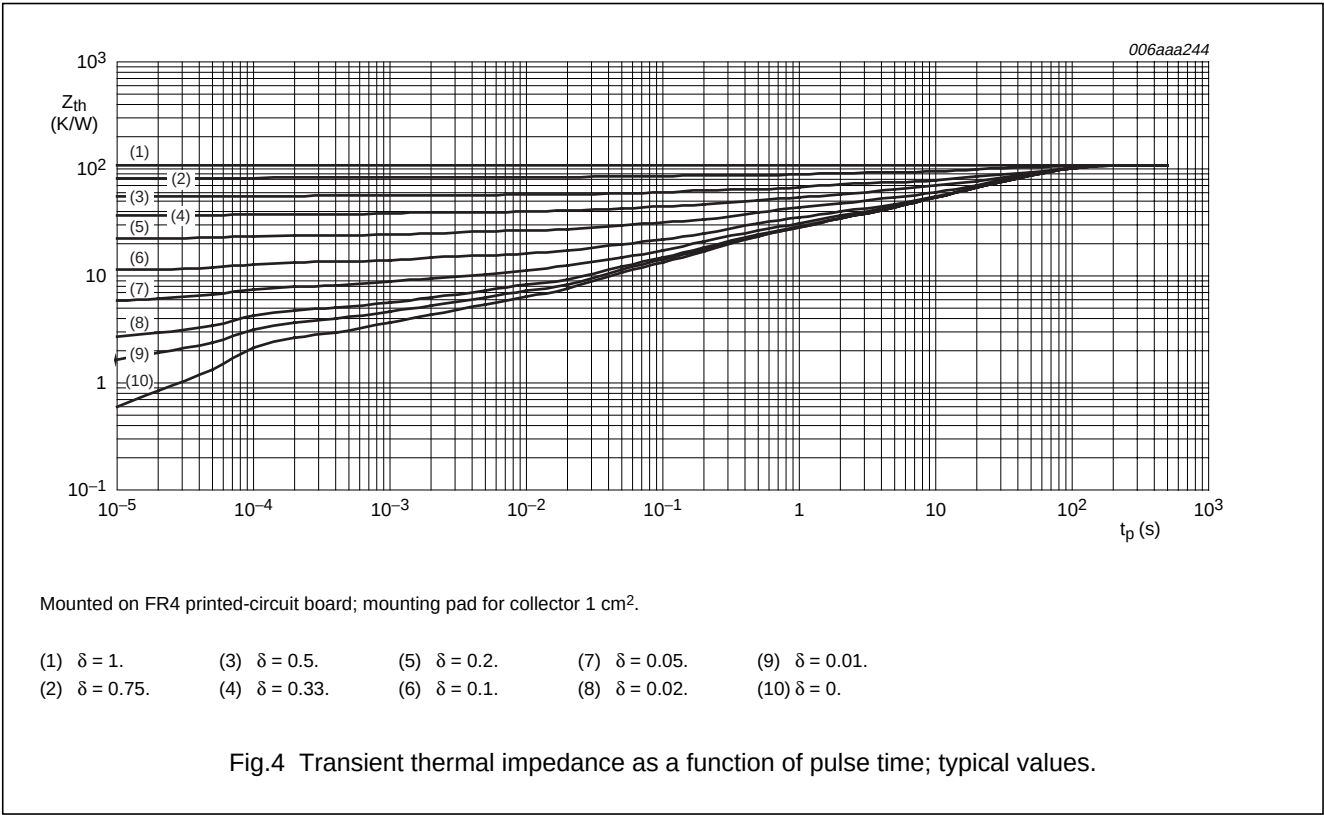
Notes

1. Device mounted on a FR4 printed-circuit board; single-sided copper; tin-plated; standard footprint.
2. Device mounted on a FR4 printed-circuit board; single-sided copper; tin-plated; mounting pad for collector 1 cm².
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50 V, 3 A NPN low V_{CEsat} (BISS) transistor

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CHARACTERISTICS $T_{amb} = 25\text{ °C}$ unless otherwise specified.

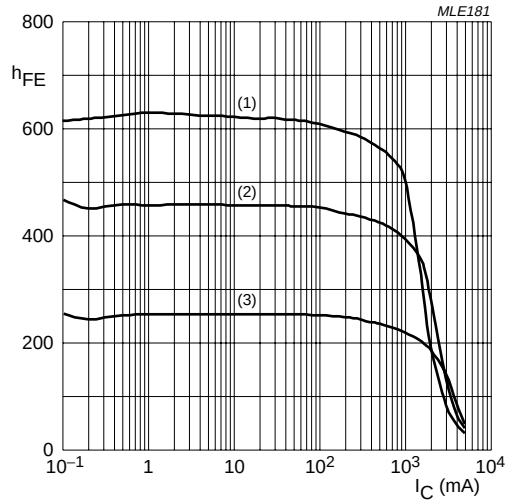
SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
I_{CBO}	collector-base cut-off current	$V_{CB} = 50\text{ V}; I_E = 0\text{ A}$	–	–	100	nA
		$V_{CB} = 50\text{ V}; I_E = 0\text{ A}; T_j = 150\text{ °C}$	–	–	50	μA
I_{CES}	collector-emitter cut-off current	$V_{CE} = 50\text{ V}; V_{BE} = 0\text{ V}$	–	–	100	nA
I_{EBO}	emitter-base cut-off current	$V_{EB} = 5\text{ V}; I_C = 0\text{ A}$	–	–	100	nA
h_{FE}	DC current gain	$V_{CE} = 2\text{ V}$				
		$I_C = 0.1\text{ A}$	300	–	–	
		$I_C = 0.5\text{ A}$	300	–	–	
		$I_C = 1\text{ A}; \text{note 1}$	300	–	700	
		$I_C = 2\text{ A}; \text{note 1}$	200	–	–	
		$I_C = 3\text{ A}; \text{note 1}$	100	–	–	
V_{CEsat}	collector-emitter saturation voltage	$I_C = 0.5\text{ A}; I_B = 50\text{ mA}$	–	–	80	mV
		$I_C = 1\text{ A}; I_B = 50\text{ mA}$	–	–	160	mV
		$I_C = 2\text{ A}; I_B = 100\text{ mA}$	–	–	280	mV
		$I_C = 2\text{ A}; I_B = 200\text{ mA}; \text{note 1}$	–	–	260	mV
		$I_C = 3\text{ A}; I_B = 300\text{ mA}; \text{note 1}$	–	–	370	mV
R_{CEsat}	equivalent on-resistance	$I_C = 2\text{ A}; I_B = 200\text{ mA}; \text{note 1}$	–	100	130	$\text{m}\Omega$
V_{BEsat}	base-emitter saturation voltage	$I_C = 2\text{ A}; I_B = 100\text{ mA}$	–	–	1.1	V
		$I_C = 3\text{ A}; I_B = 300\text{ mA}; \text{note 1}$	–	–	1.2	V
V_{BEon}	base-emitter turn-on voltage	$V_{CE} = 2\text{ V}; I_C = 1\text{ A}$	1.1	–	–	V
f_T	transition frequency	$I_C = 100\text{ mA}; V_{CE} = 5\text{ V}; f = 100\text{ MHz}$	100	–	–	MHz
C_c	collector capacitance	$V_{CB} = 10\text{ V}; I_E = I_e = 0\text{ A}; f = 1\text{ MHz}$	–	–	25	pF

Note

1. Pulse test: $t_p \leq 300\text{ }\mu\text{s}$; $\delta \leq 0.02$.

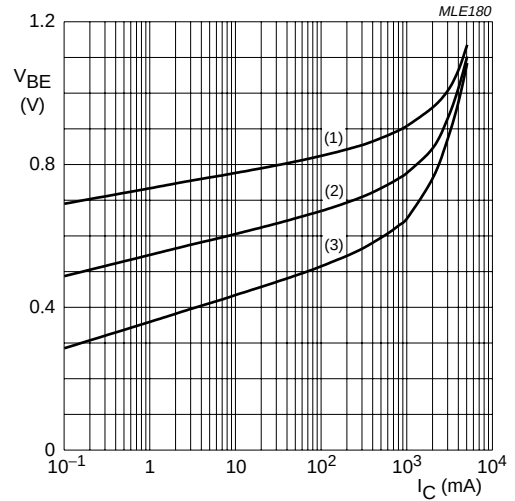
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 $V_{CE} = 2 \text{ V.}$

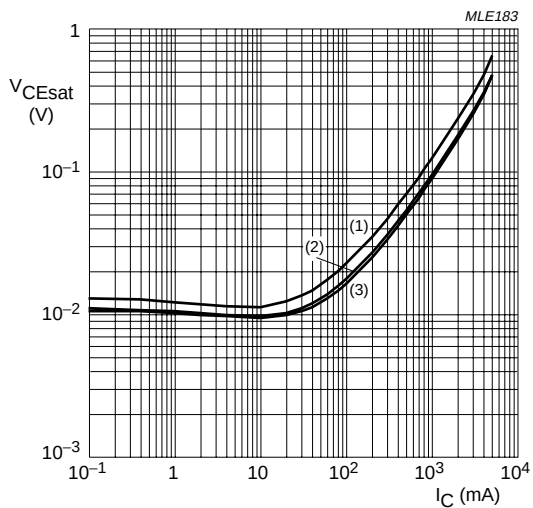
- (1) $T_{amb} = 100 \text{ }^{\circ}\text{C.}$
 (2) $T_{amb} = 25 \text{ }^{\circ}\text{C.}$
 (3) $T_{amb} = -55 \text{ }^{\circ}\text{C.}$

Fig.6 DC current gain as a function of collector current; typical values.

 $V_{CE} = 2 \text{ V.}$

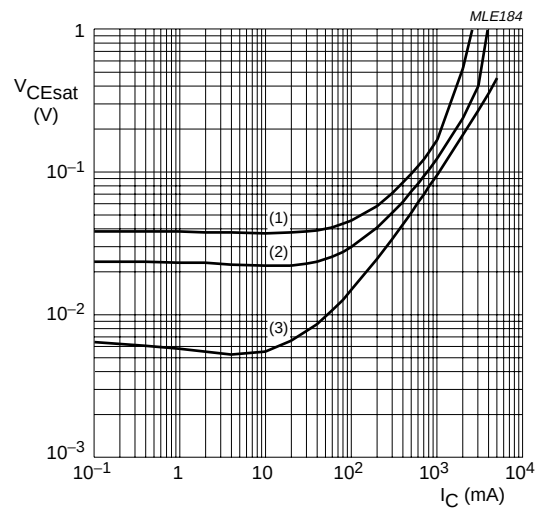
- (1) $T_{amb} = -55 \text{ }^{\circ}\text{C.}$
 (2) $T_{amb} = 25 \text{ }^{\circ}\text{C.}$
 (3) $T_{amb} = 100 \text{ }^{\circ}\text{C.}$

Fig.7 Base-emitter voltage as a function of collector current; typical values.

 $I_C/I_B = 20.$

- (1) $T_{amb} = 100 \text{ }^{\circ}\text{C.}$
 (2) $T_{amb} = 25 \text{ }^{\circ}\text{C.}$
 (3) $T_{amb} = -55 \text{ }^{\circ}\text{C.}$

Fig.8 Collector-emitter saturation voltage as a function of collector current; typical values.

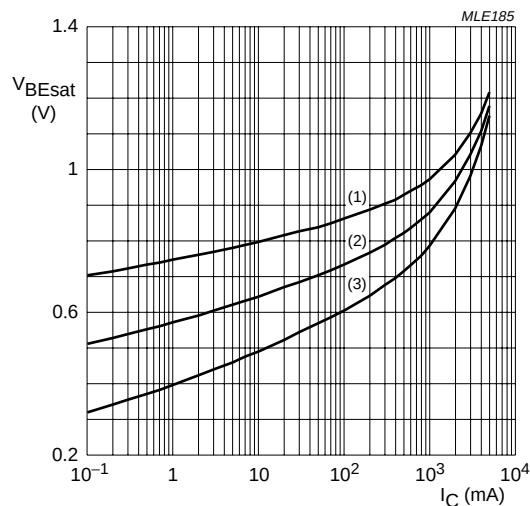
 $T_{amb} = 25 \text{ }^{\circ}\text{C.}$

- (1) $I_C/I_B = 100.$
 (2) $I_C/I_B = 50.$
 (3) $I_C/I_B = 10.$

Fig.9 Collector-emitter saturation voltage as a function of collector current; typical values.

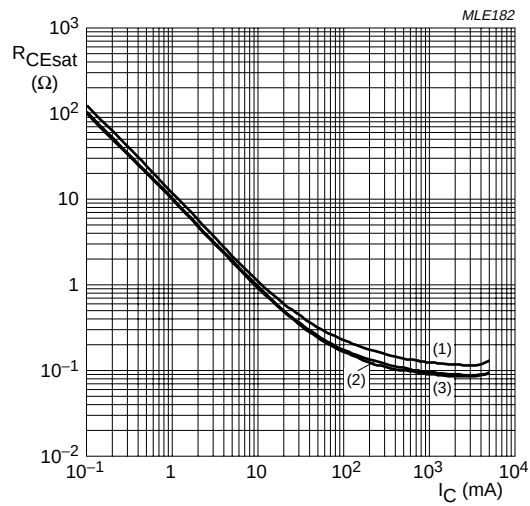
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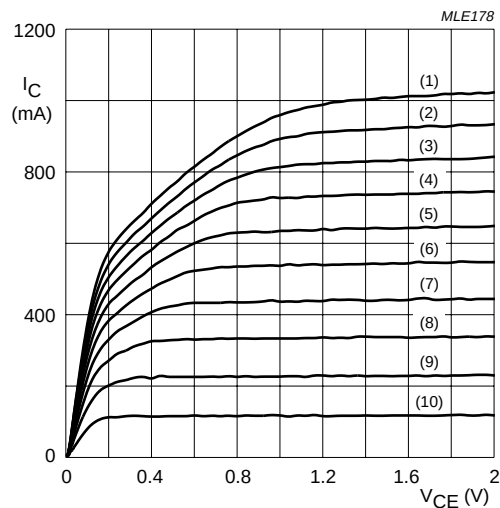
$I_C/I_B = 20$.
(1) $T_{amb} = -55^\circ C$. (2) $T_{amb} = 25^\circ C$. (3) $T_{amb} = 100^\circ C$.

Fig.10 Base-emitter saturation voltage as a function of collector current; typical values.



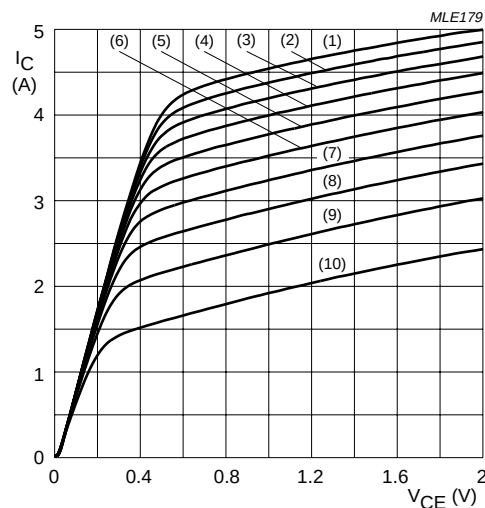
$I_C/I_B = 20$.
(1) $T_{amb} = 150^\circ C$. (2) $T_{amb} = 25^\circ C$. (3) $T_{amb} = -55^\circ C$.

Fig.11 Equivalent on-resistance as a function of collector current; typical values.



$T_{amb} = 25^\circ C$.
(1) $I_B = 2600 \mu A$. (5) $I_B = 1560 \mu A$. (9) $I_B = 520 \mu A$.
(2) $I_B = 2340 \mu A$. (6) $I_B = 1300 \mu A$. (10) $I_B = 260 \mu A$.
(3) $I_B = 2080 \mu A$. (7) $I_B = 1040 \mu A$.
(4) $I_B = 1820 \mu A$. (8) $I_B = 780 \mu A$.

Fig.12 Collector current as a function of collector-emitter voltage; typical values.



$T_{amb} = 25^\circ C$.
(1) $I_B = 120 mA$. (5) $I_B = 72 mA$. (9) $I_B = 24 mA$.
(2) $I_B = 108 mA$. (6) $I_B = 60 mA$. (10) $I_B = 12 mA$.
(3) $I_B = 96 mA$. (7) $I_B = 48 mA$.
(4) $I_B = 84 mA$. (8) $I_B = 36 mA$.

Fig.13 Collector current as a function of collector-emitter voltage; typical values.

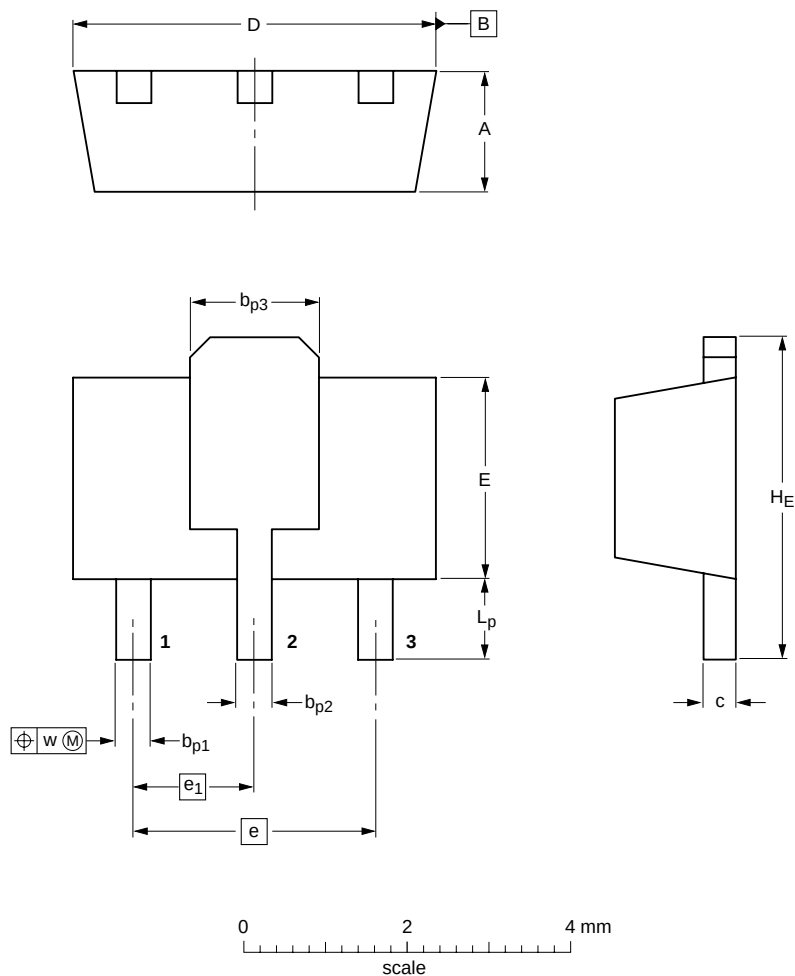
50 V, 3 A
NPN low V_{CEsat} (BISS) transistor

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PACKAGE OUTLINE

Plastic surface mounted package; collector pad for good heat transfer; 3 leads

SOT89



DIMENSIONS (mm are the original dimensions)

UNIT	A	b_{p1}	b_{p2}	b_{p3}	c	D	E	e	e_1	H_E	L_p	w
mm	1.6 1.4	0.48 0.35	0.53 0.40	1.8 1.4	0.44 0.23	4.6 4.4	2.6 2.4	3.0	1.5	4.25 3.75	1.2 0.8	0.13

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	JEITA			
SOT89		TO-243	SC-62			99-09-13 04-08-03

50 V, 3 A NPN low V_{CEsat} (BISS) transistor

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DATA SHEET STATUS

LEVEL	DATA SHEET STATUS ⁽¹⁾	PRODUCT STATUS ⁽²⁾⁽³⁾	DEFINITION
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II	Preliminary data	Qualification	This data sheet contains data from the preliminary specification. Supplementary data will be published at a later date. Philips Semiconductors reserves the right to change the specification without notice, in order to improve the design and supply the best possible product.
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Contact information

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